

N-Ch MOSFET

General Description

The WSF40N06S is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF40N06S meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

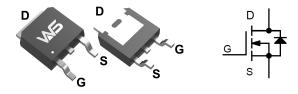
Product Summery

BVDSS	RDSON	ID
60V	22mΩ	40A

Applications

- Battery protection
- Load switch
- Uninterruptible power supply

TO-252 Pin Configuration



Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	60	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	40	A
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	25	A
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	7.4	A
I _D @T _A =70℃	Continuous Drain Current, V _{GS} @ 10V ¹	6.0	A
I _{DM}	Pulsed Drain Current ²	90	A
EAS	Single Pulse Avalanche Energy ³	39.2	mJ
I _{AS}	Avalanche Current	28	A
P₀@T₀=25℃	Total Power Dissipation ⁴	45	W
P _D @T _A =25℃	Total Power Dissipation ⁴	2.0	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹		62	°C/W
R _{eJC}	Thermal Resistance Junction-Case ¹		2	°C/W



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ \! \mathrm{C}$, I_D=1mA		0.057		V/℃
Р	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =20A		22	25	mΩ
R _{DS(ON)}		V _{GS} =4.5V , I _D =10A		25	30	
V _{GS(th)}	Gate Threshold Voltage		1.2	1.8	2.5	V
_V _{GS(th)}	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_{D}=250$ uA		-5.68		mV/°C
	Drain-Source Leakage Current	V_{DS} =48V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			1	uA
I _{DSS}		V _{DS} =48V , V _{GS} =0V , T _J =55℃			5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =15A		45		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =30V , V _{GS} =4.5V , I _D =15A		19.3		
Q _{gs}	Gate-Source Charge			7.1		nC
Q _{gd}	Gate-Drain Charge			7.6		
T _{d(on)}	Turn-On Delay Time	V _{DD} =30V , V _{GS} =10V , R _G =3.3Ω, I _D =15A		7.2		
Tr	Rise Time			50		
T _{d(off)}	Turn-Off Delay Time			36.4		ns
T _f	Fall Time			7.6		
Ciss	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		2423		
C _{oss}	Output Capacitance			145		pF
C _{rss}	Reverse Transfer Capacitance			97]

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,6}	$-V_G=V_D=0V$, Force Current			35	А
I _{SM}	Pulsed Source Current ^{2,6}				80	A
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =20A , TJ=25℃			1.2	V
t _{rr}	Reverse Recovery Time			16.3		nS
Qrr	Reverse Recovery Charge	IF=1A ,dI/dt=100A/µs,TJ=25℃		11		nC

Note :

1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=28A

4.The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature

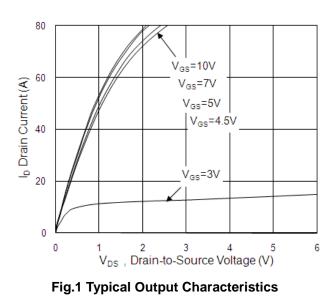
5. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation

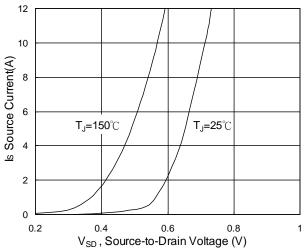


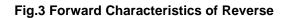
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Typical Characteristics







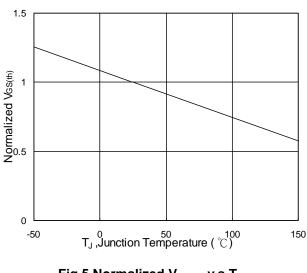


Fig.5 Normalized V_{GS} v.s T_J

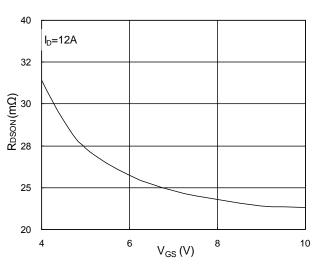


Fig.2 On-Resistance v.s Gate-Source

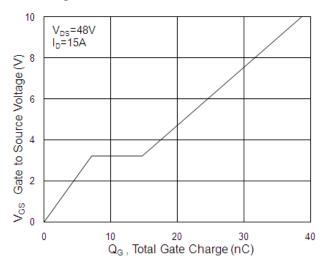


Fig.4 Gate-Charge Characteristics

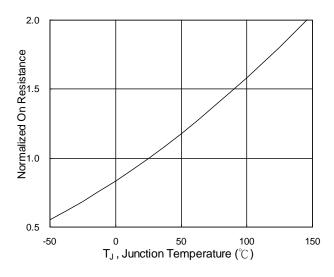


Fig.6 Normalized R_{DSON} v.s T_J



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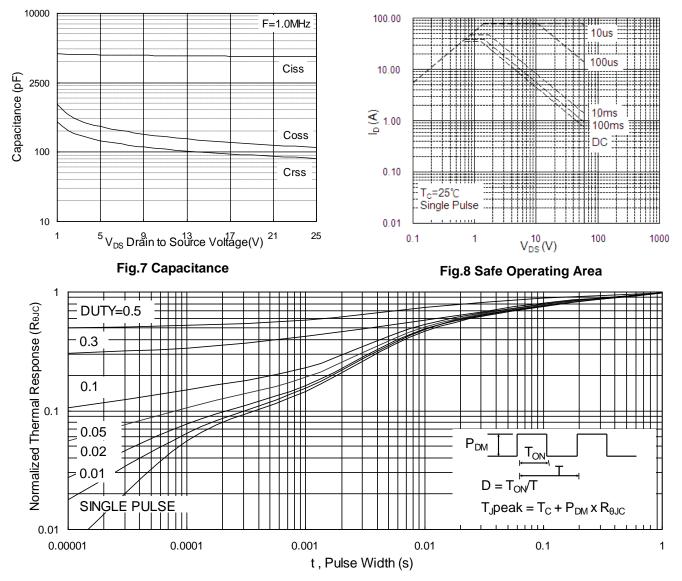
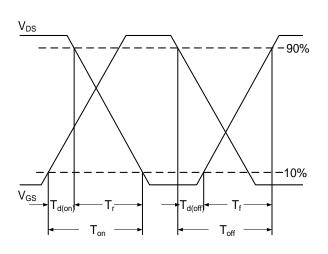


Fig.9 Normalized Maximum Transient Thermal Impedance





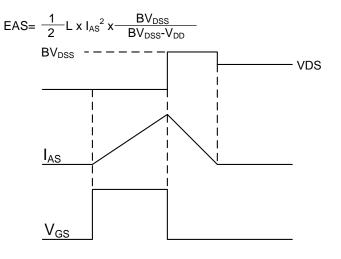


Fig.11 Unclamped Inductive Switching Waveform



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